

## TeraNova High Endurance

SATA III 6Gbps SSD



Targeted at the Pro/Enthusiast seeking extreme performance, the TeraNova is one of several durable 2.5" SSD's that SuperTalent has released to date. Featuring the SATA3 Interface with optimized firmware, the SuperTalent TeraNova is built for reliable speed. By optimizing the transfer rate at various queue depths, the TeraNova delivers excellent performance in a variety of conditions. Sure the TeraNova boots quickly and posts outstanding benchmark scores (over 560MB/s for read and 490MB/s for write), but the TeraNova also excels in general responsiveness.

The TeraNova also includes new features that enhance reliability as well. In the event of a sudden power loss, the TeraNova reacts, protecting valuable data from corruption before it powers off.

## Physical Specifications

| 2.5"                     |
|--------------------------|
| 256GB-1TB                |
| 69.85 x 100.00 x 7.00 mm |
| SATA III                 |
| TLC                      |
| 5V ± 10%                 |
| Metal housing            |
| 560/490                  |
|                          |

## **Environmental Specifications**

| Operating Shock       | 1500G ( duration : 0.5ms ) |
|-----------------------|----------------------------|
| Operating Vibration   | 20G ( 7Hz~2KHz )           |
| Operating Temperature | 0C to +70C                 |
| Operating Humidity    | 0% to ~95% RH              |

## Ordering Information

| Capacity(TLC) | Commercial Temp |
|---------------|-----------------|
| 256GB         | FTA256112F      |
| 512GB         | FTA512112F      |
| 1TB           | FTA1T0112F      |

\*EOL Part Number : FTM\*\*\*325H

© 2019 Super Talent Technology. Specifications subject to change without notice. US patent # 6,547,130 and others apply. 1GB=1,000,000,000 Bytes. Usable capacity may be less than specified after formatting. Performance rating based on ATTO Disk Benchmark scores. Actual performance varies depending upon the system configuration and the application used. Performance is highly dependent upon test environment and use case.